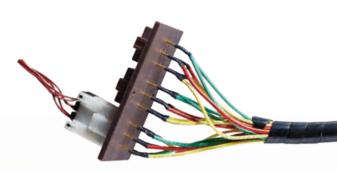
## Order-made according to inspection targets.

# Unit assemblies for inspections

#### Assembly

This is a unit component that further increases the efficiency in inspection using a probe. The interface corresponding to IC testers can be used to perform settings for probe configuration and board thickness, etc., according to inspection targets. Also, pin bases can be designed and manufactured to enable probe contact during inspections of board connector terminals. Individual probes can be replaced easily.



### Product features

- Design and manufacture are possible based on inspection targets
- Housing materials can be proposed based on usage applications
- Contributes to increased inspection and maintenance efficiency

#### **Product applications**

IC tester connections, ECU unit inspections, etc.

